Random bad cell map for wafer 166 s/n: Y21316-12-08

Date: 07/01/99

		0	0	1		0		
		0	0	0	0	0		
	0	0	24	0			0	
	0	0	0		0	4	0	
0	0	0	1		0	0	0	19
0	0	1	9	22		0	8	139
0	0	0	52	49	22	1	0	0
	0	2	61	37	58	0	0	
0			53	6		1	0	
0			40		53	0	0	
79	38	3	38		20		0	0
22	0	285	9	26			0	6
	0	0	4	5	3	0	0	0
	0	0	0	1	0	0	0	0
	0	0		0	0	0	0	
	7	0		0	0	0	0	
				0	0	0		
				0	0	0		

#	Number of bad cells in random locations
	No info